

US00D575809S

(12) **United States Design Patent**
Hebiishi

(10) **Patent No.:** **US D575,809 S**
(45) **Date of Patent:** **** Aug. 26, 2008**

(54) **IMAGE PICKUP MICROSCOPE**

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(73) Assignee: **Olympus Corporation**, Tokyo (JP)

(**) Term: **14 Years**

(21) Appl. No.: **29/278,892**

(22) Filed: **Apr. 12, 2007**

(30) **Foreign Application Priority Data**

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Oct. 16, 2006	(JP)	2006-028008
Oct. 16, 2006	(JP)	2006-028009
Oct. 16, 2006	(JP)	2006-028010
Oct. 16, 2006	(JP)	2006-028011

(51) **LOC (8) Cl.** **16-06**

(52) **U.S. Cl.** **D16/131**

(58) **Field of Classification Search** D16/131;
359/363, 368, 369, 382; D3/294, 903; D21/483
See application file for complete search history.

(56) **References Cited**

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Primary Examiner—Paula A Greene

(74) *Attorney, Agent, or Firm*—Hogan & Hartson LLP

(57) **CLAIM**

The ornamental design for an image pickup microscope, as shown and described.

DESCRIPTION

FIG. 1 is a front elevational view of an image pickup microscope, showing my new design;

FIG. 2 is a rear elevational view thereof;

FIG. 3 is a top plan view thereof;

FIG. 4 is a bottom plan view thereof;

FIG. 5 is a left side elevational view thereof;

FIG. 6 is a right side elevational view thereof;

FIG. 7 is a perspective view thereof with a cover in an opened state, the undisclosed portions are not part of the claimed design;

FIG. 8 is a front elevational view of a second embodiment of an image pickup microscope showing my new design;

FIG. 9 is a rear elevational view thereof;

FIG. 10 is a top plan view thereof;

FIG. 11 is a bottom plan view thereof;

FIG. 12 is a left side elevational view thereof;

FIG. 13 is a right side elevational view thereof;

FIG. 14 is a front elevational view of a third embodiment of an image pickup microscope showing my new design;

FIG. 15 is a rear elevational view thereof;

FIG. 16 is a top plan view thereof;

FIG. 17 is a bottom plan view thereof;

FIG. 18 is a left side elevational view thereof;

FIG. 19 is a right side elevational view thereof;

FIG. 20 is a front elevational view of a fourth embodiment of an image pickup microscope showing my new design;

FIG. 21 is a rear elevational view thereof;

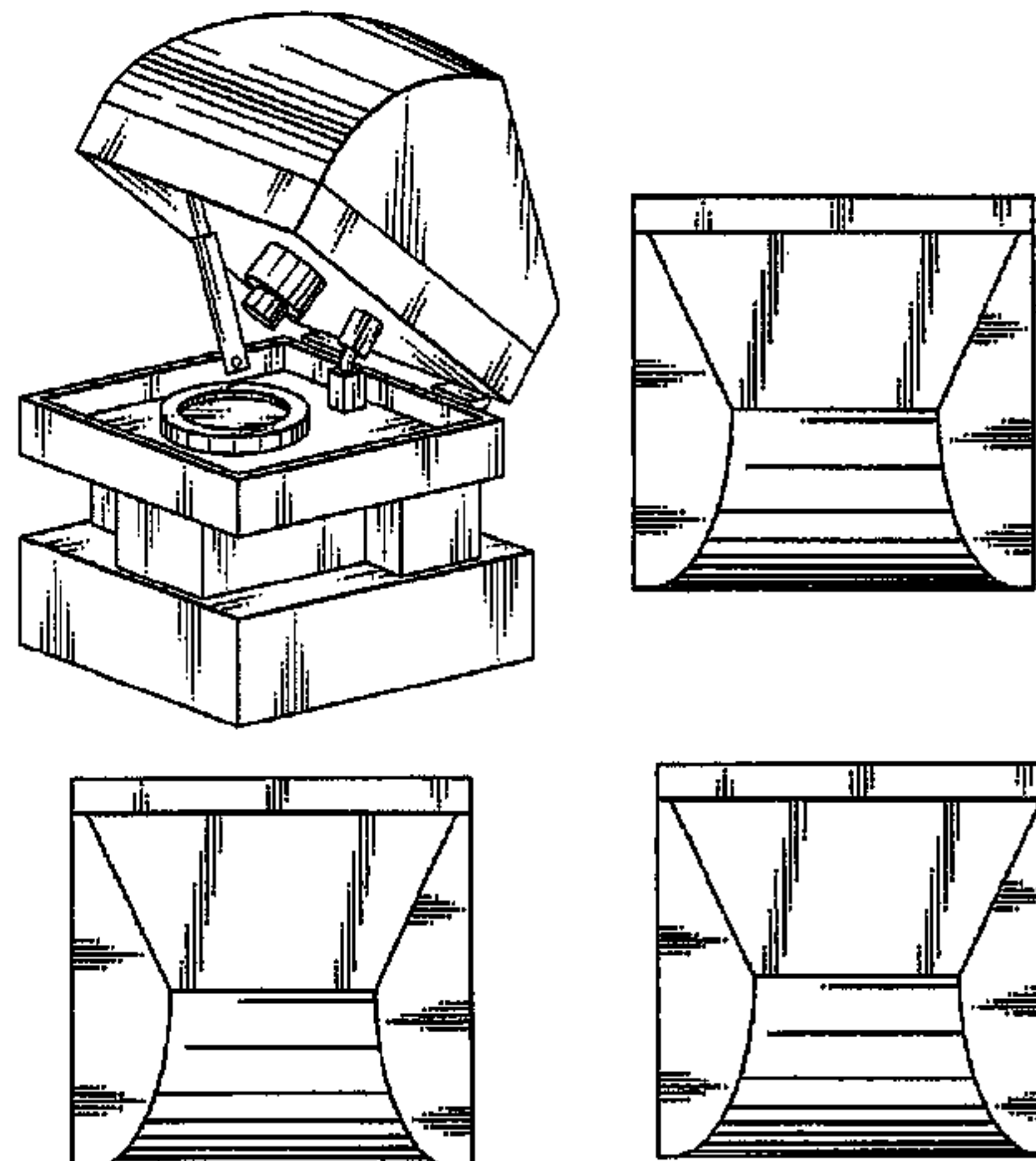
FIG. 22 is a top plan view thereof;

FIG. 23 is a bottom plan view thereof;

FIG. 24 is a left side elevational view thereof; and,

FIG. 25 is a right side elevational view thereof.

1 Claim, 5 Drawing Sheets



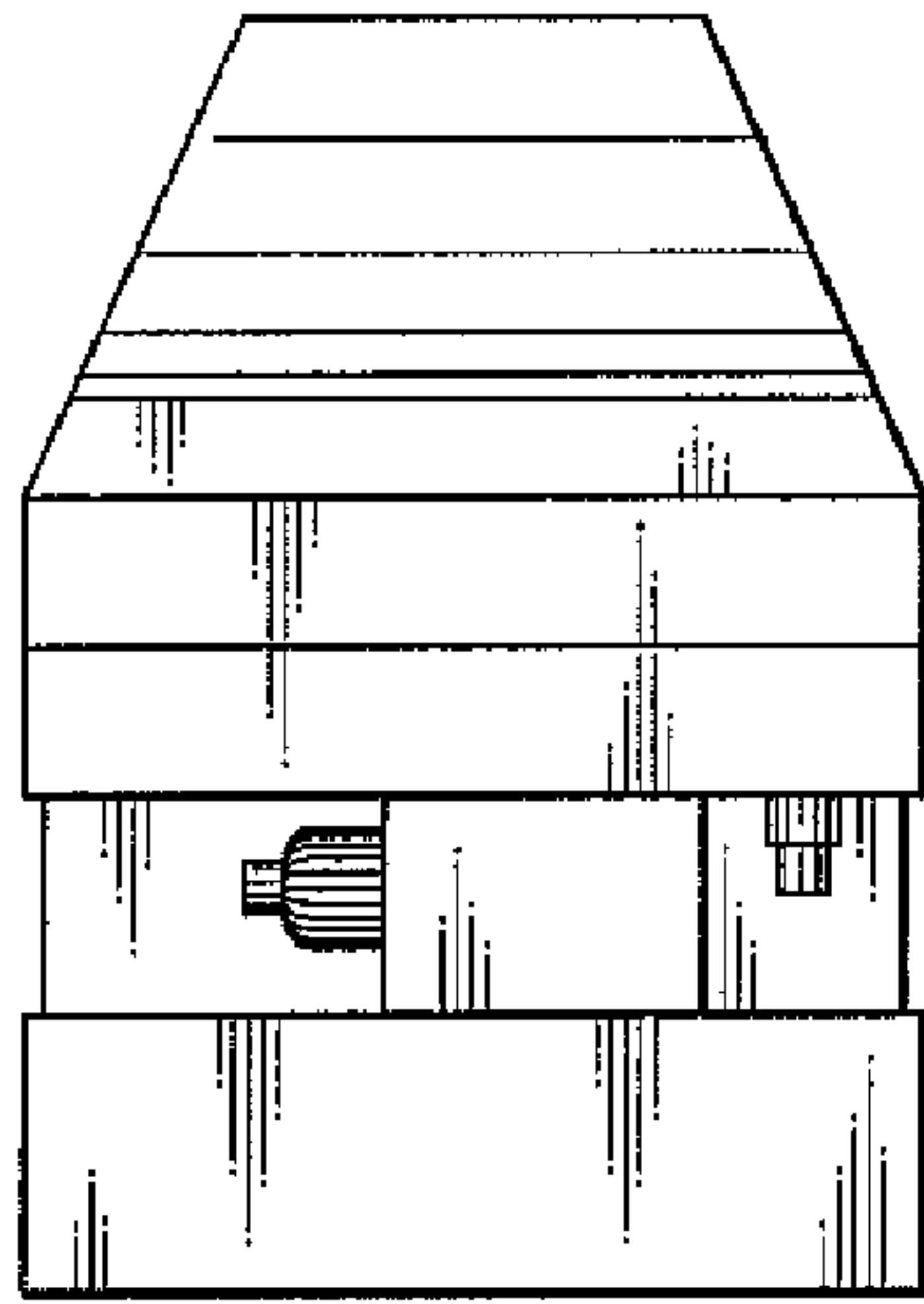


FIG. 1

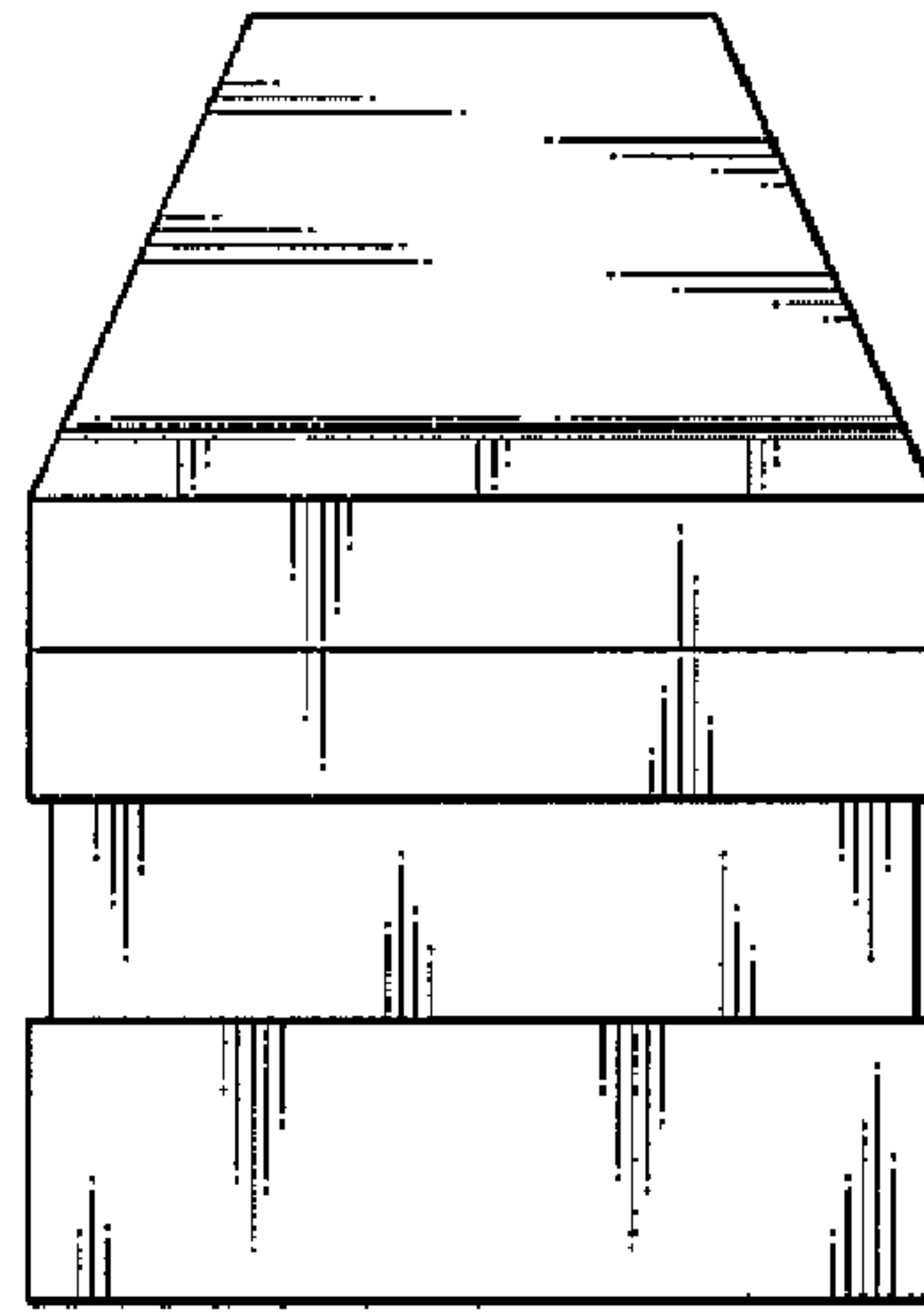


FIG. 2

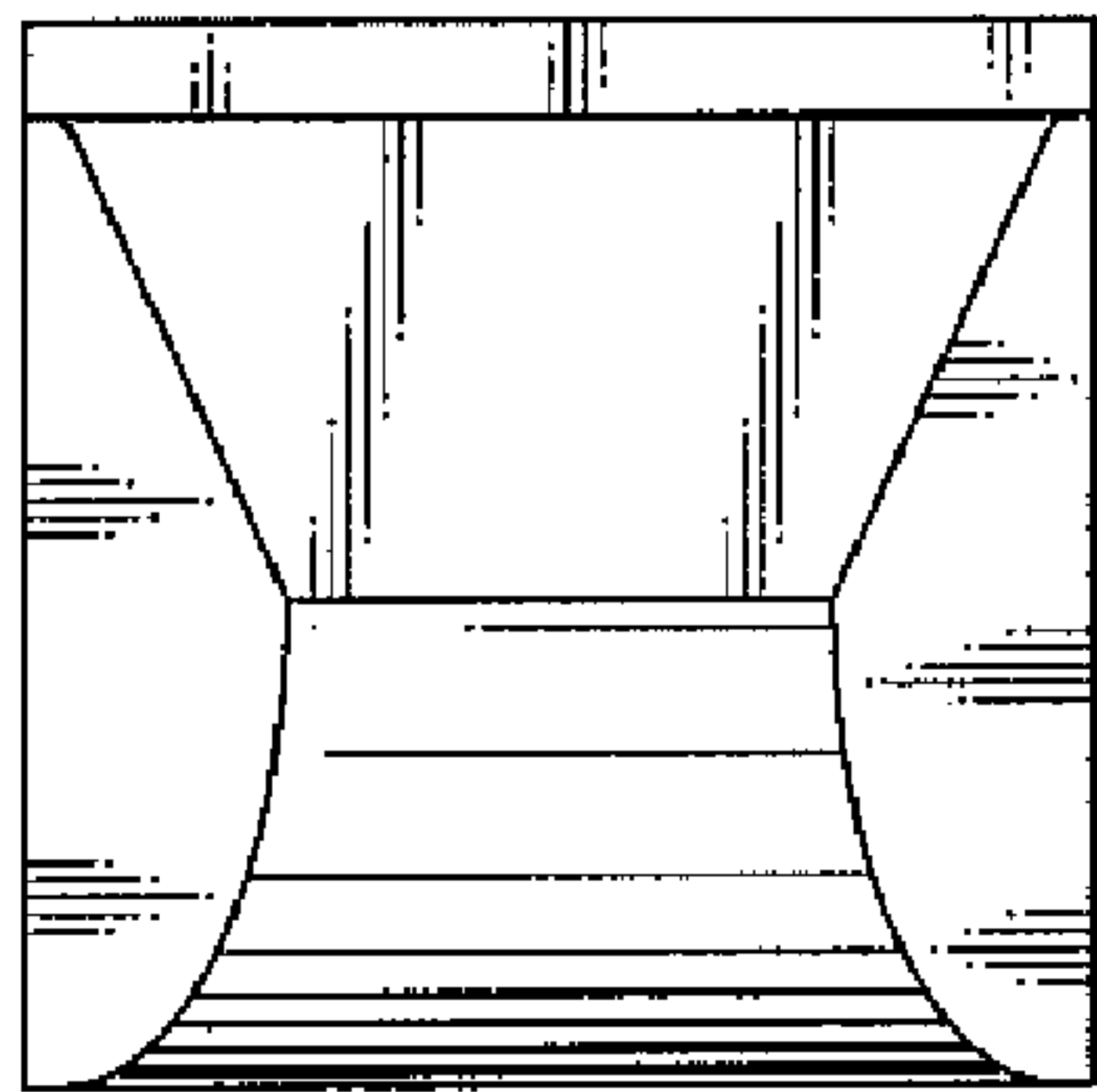


FIG. 3

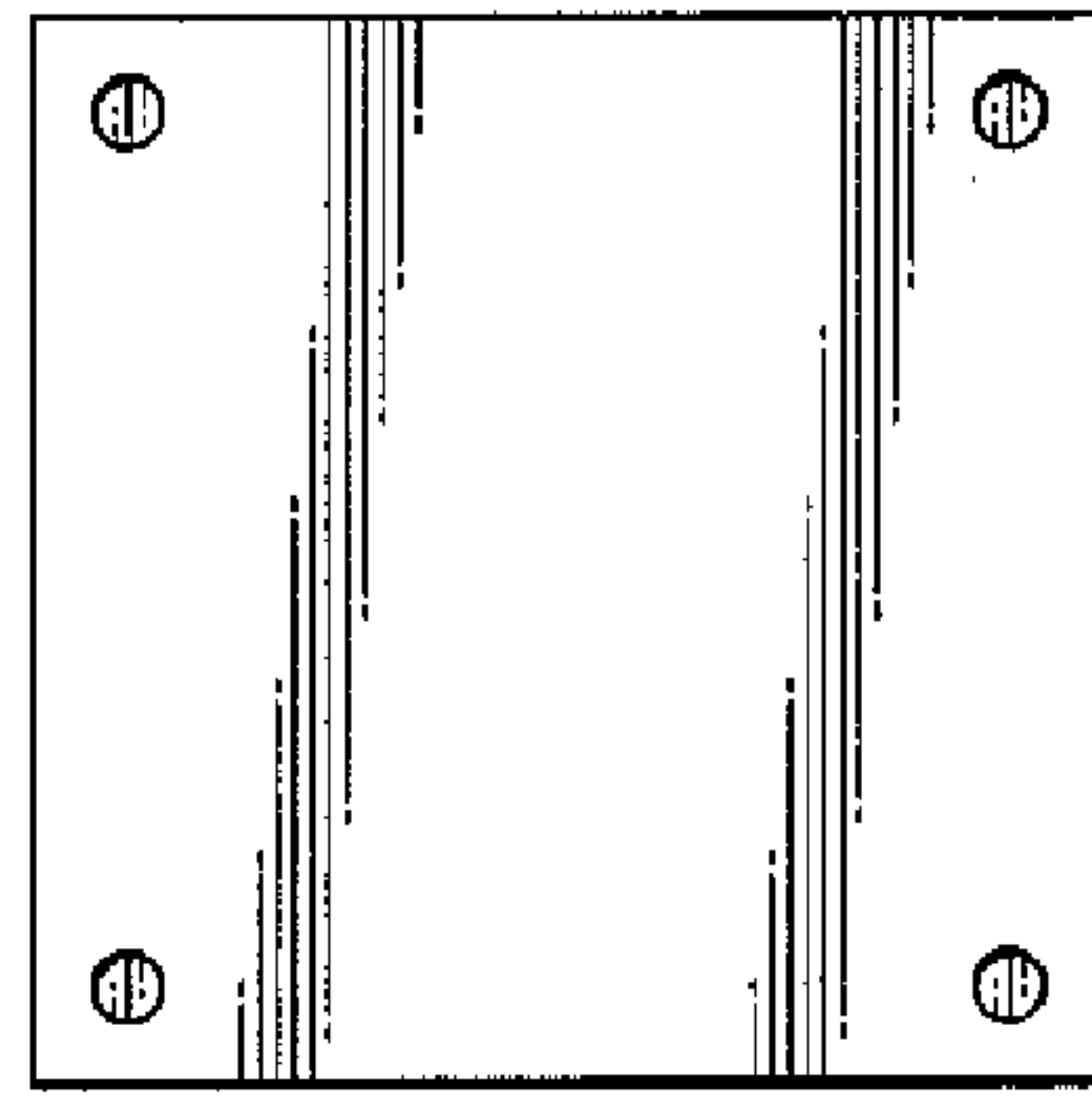


FIG. 4

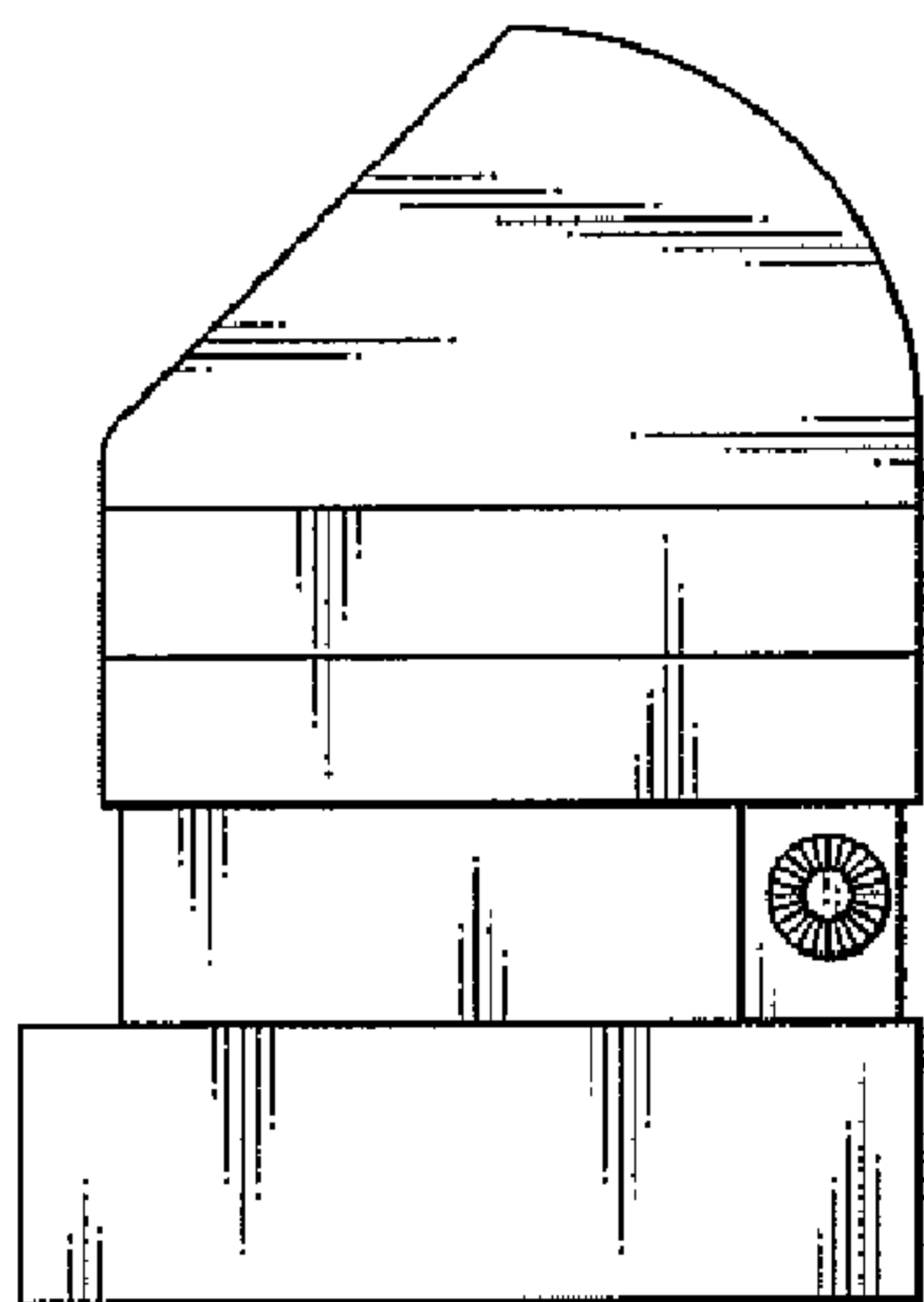


FIG. 5

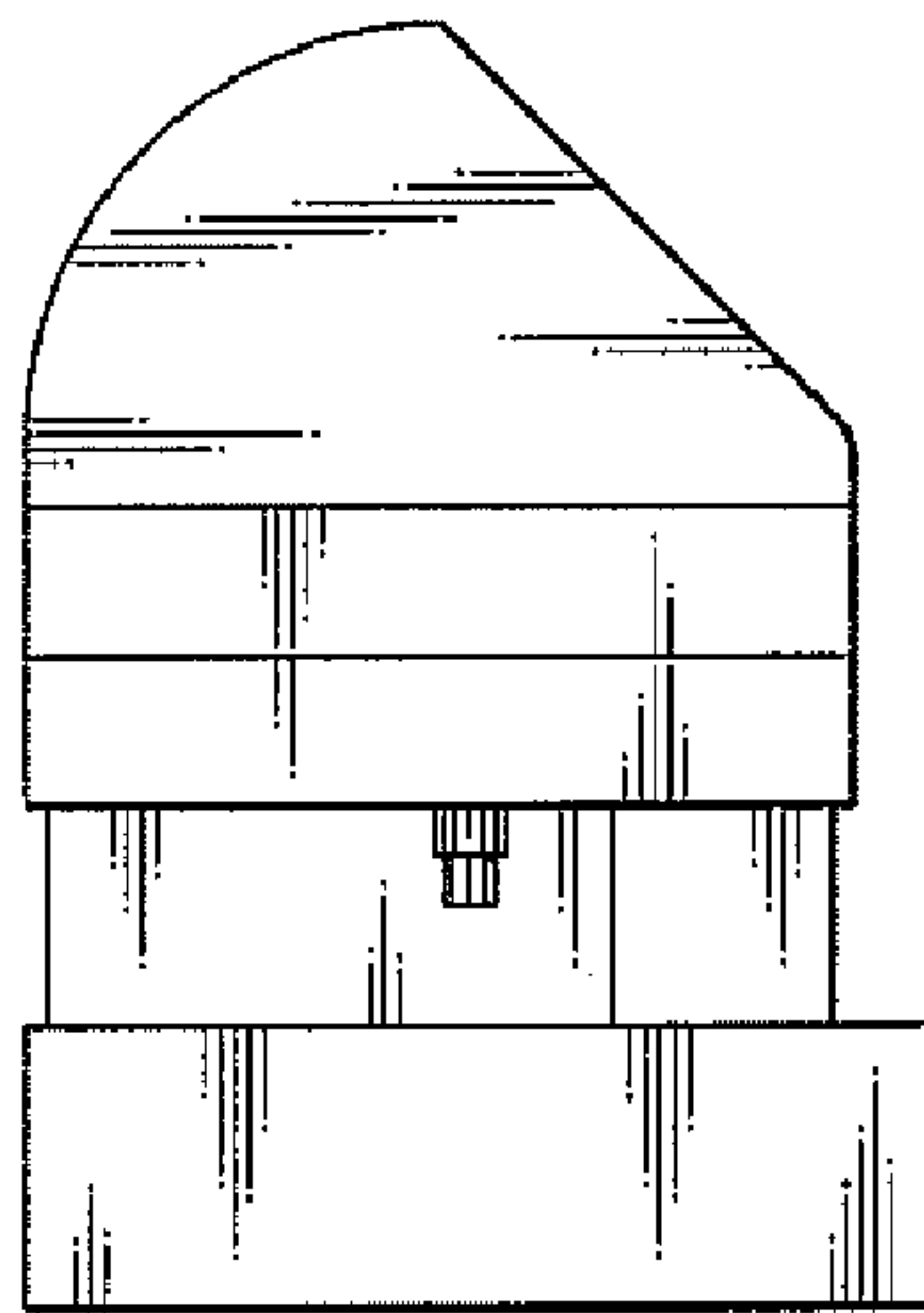


FIG. 6

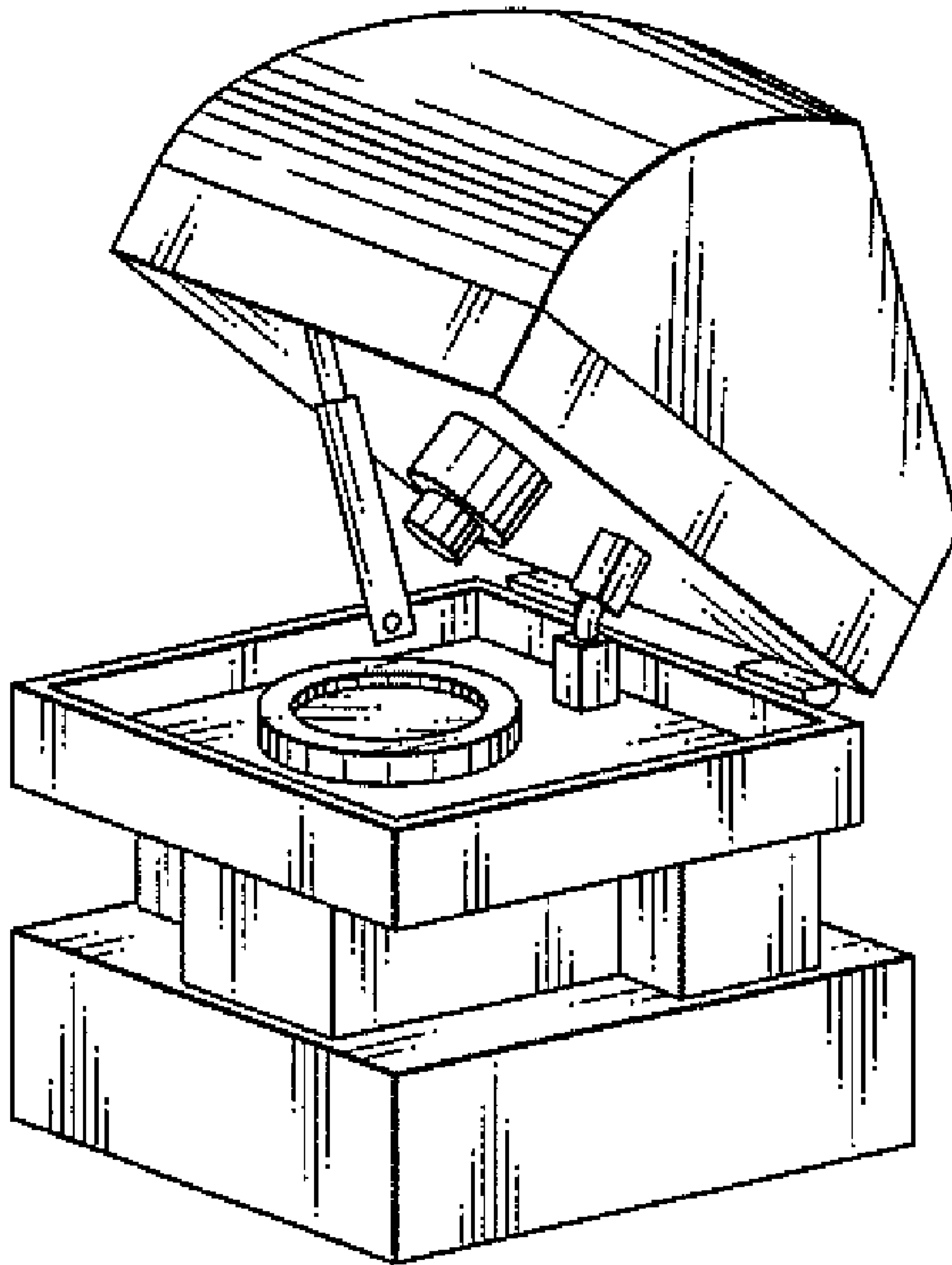


FIG. 7

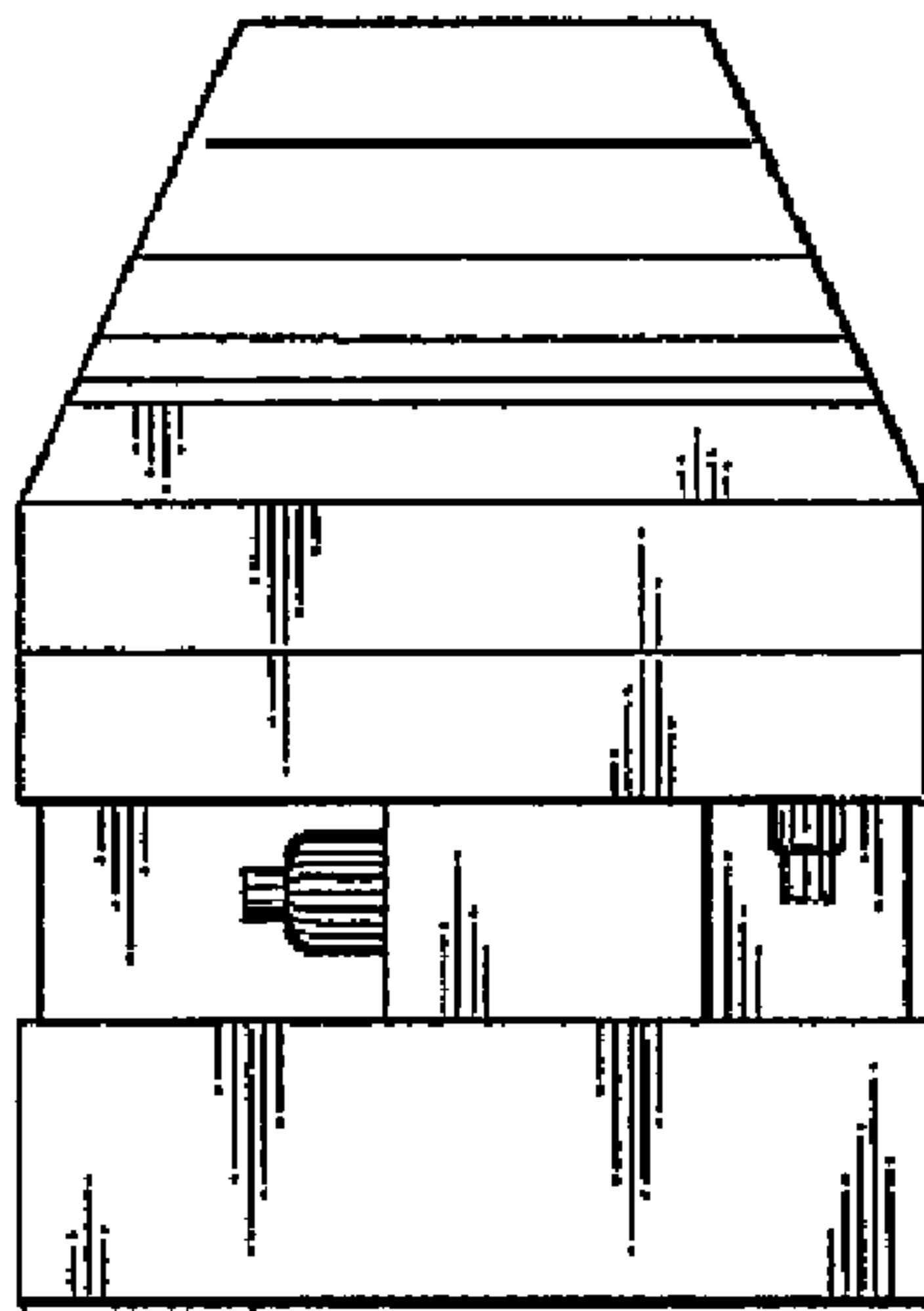


FIG. 8

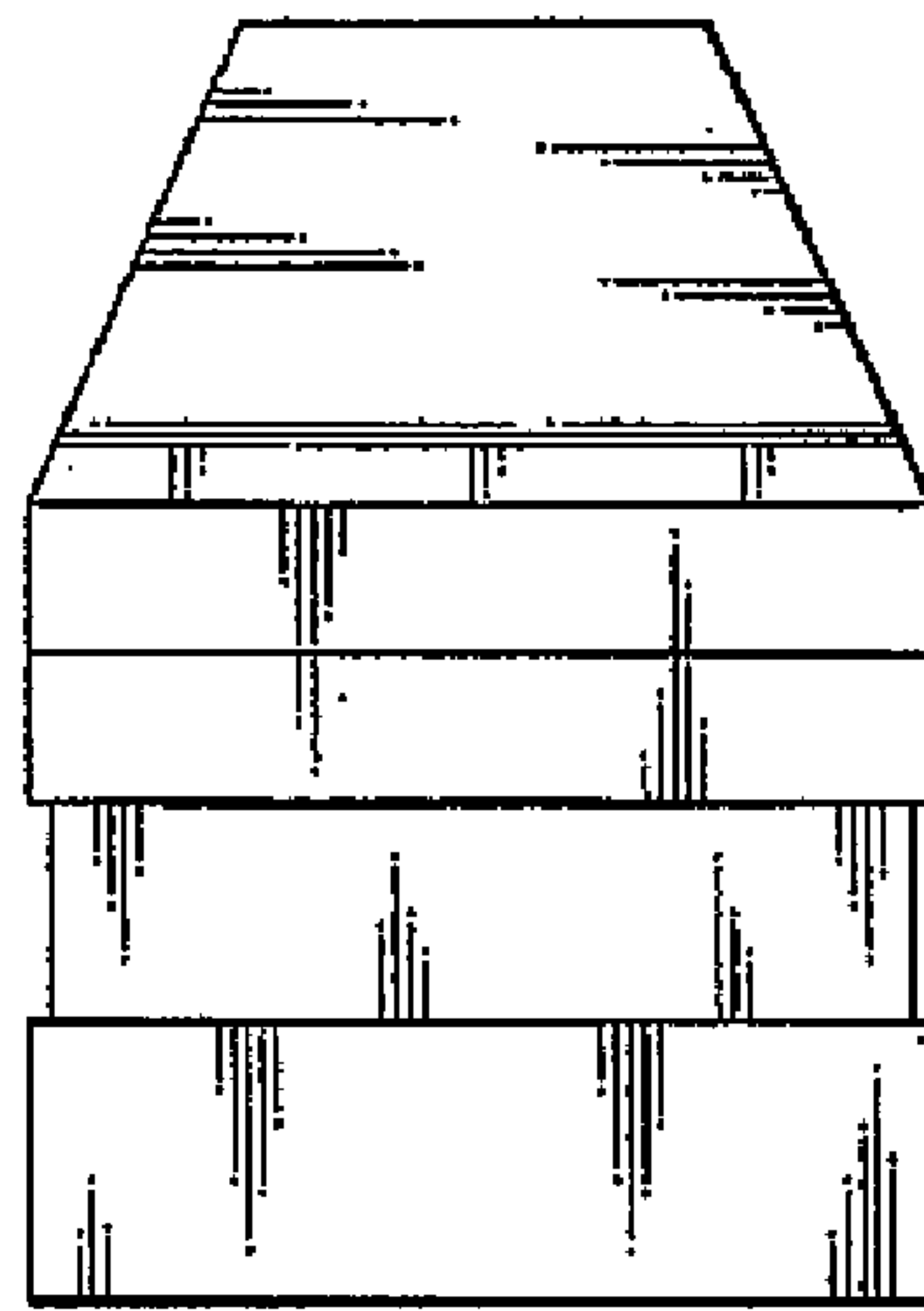


FIG. 9

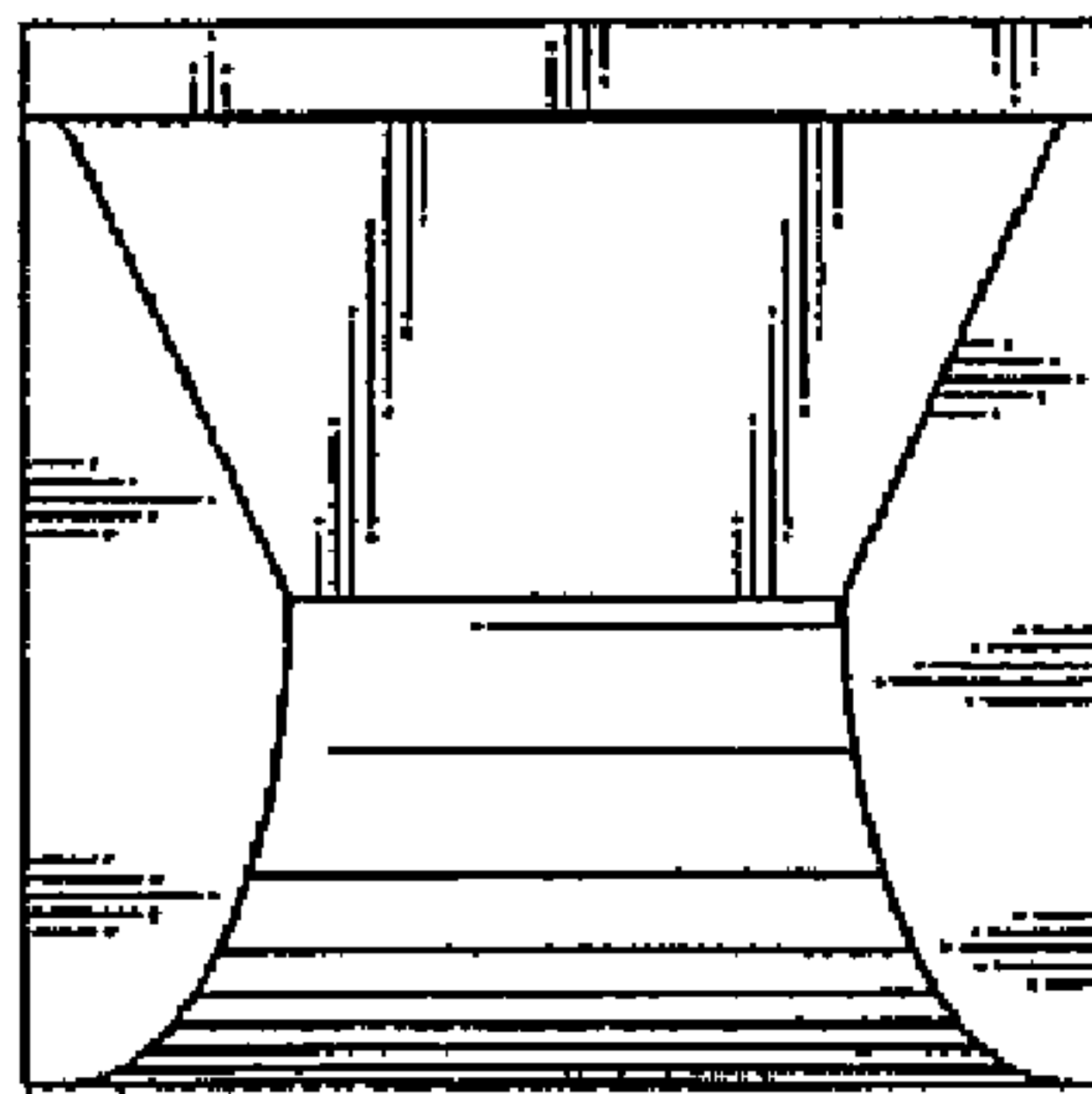


FIG. 10

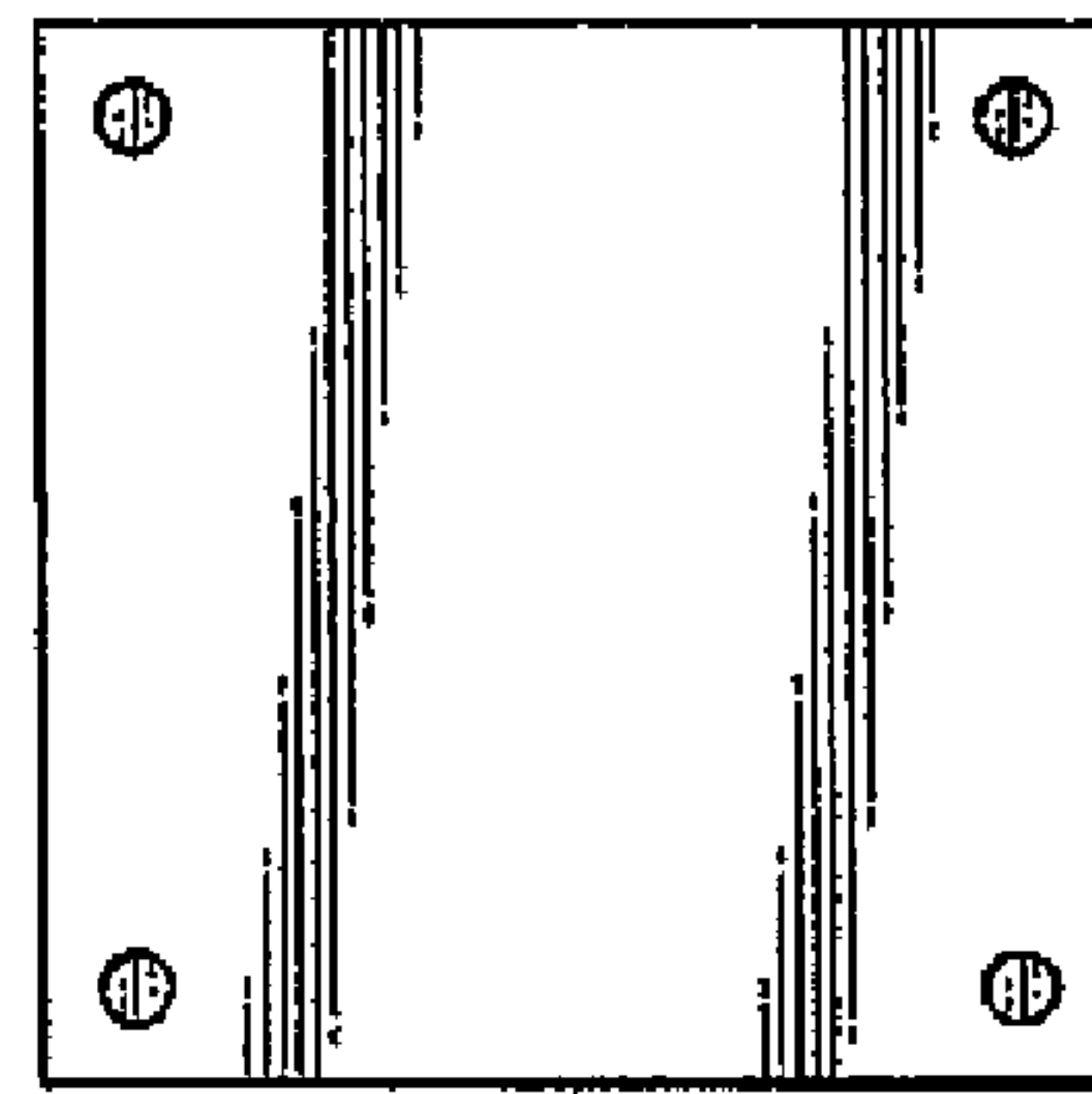


FIG. 11

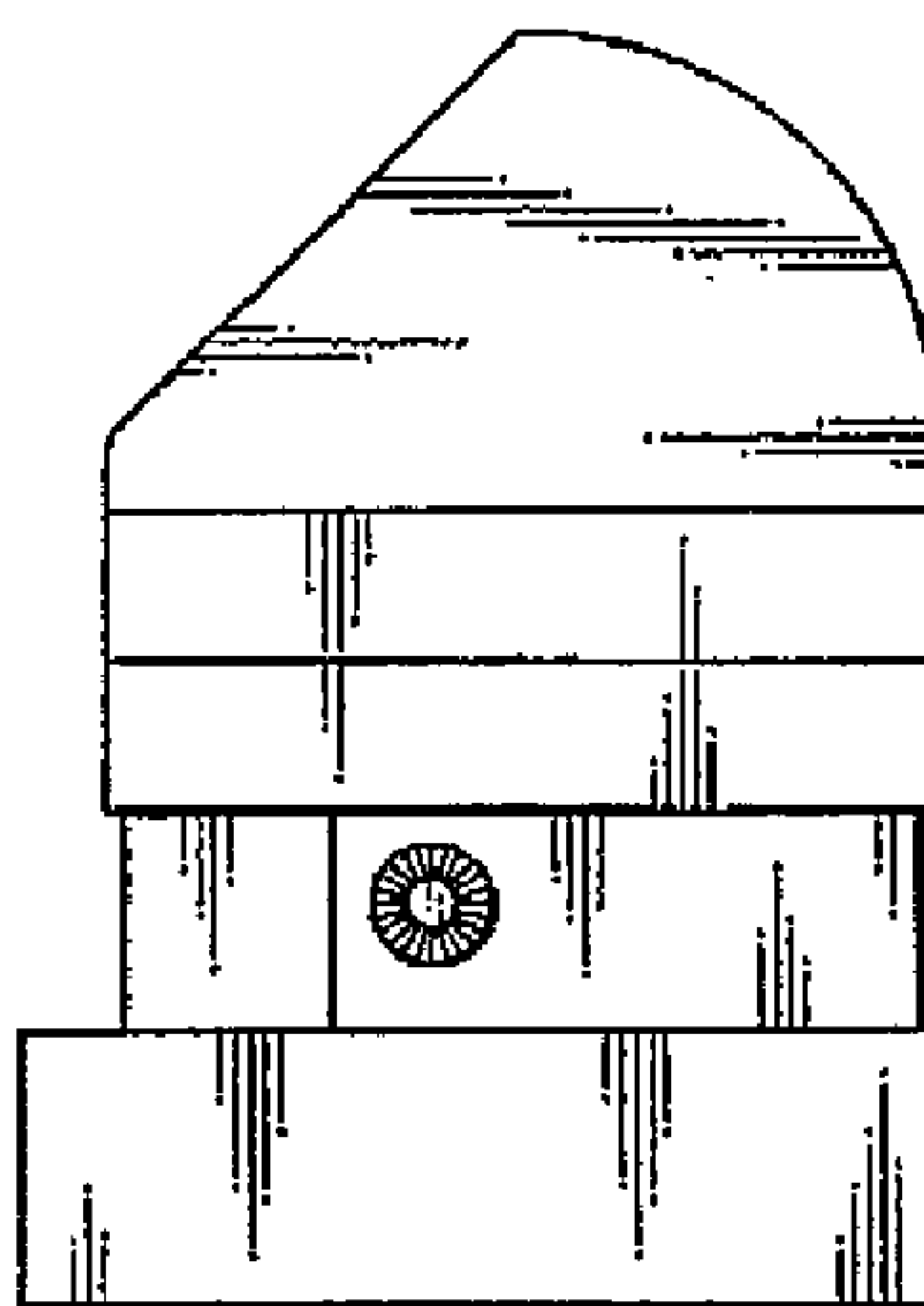


FIG. 12

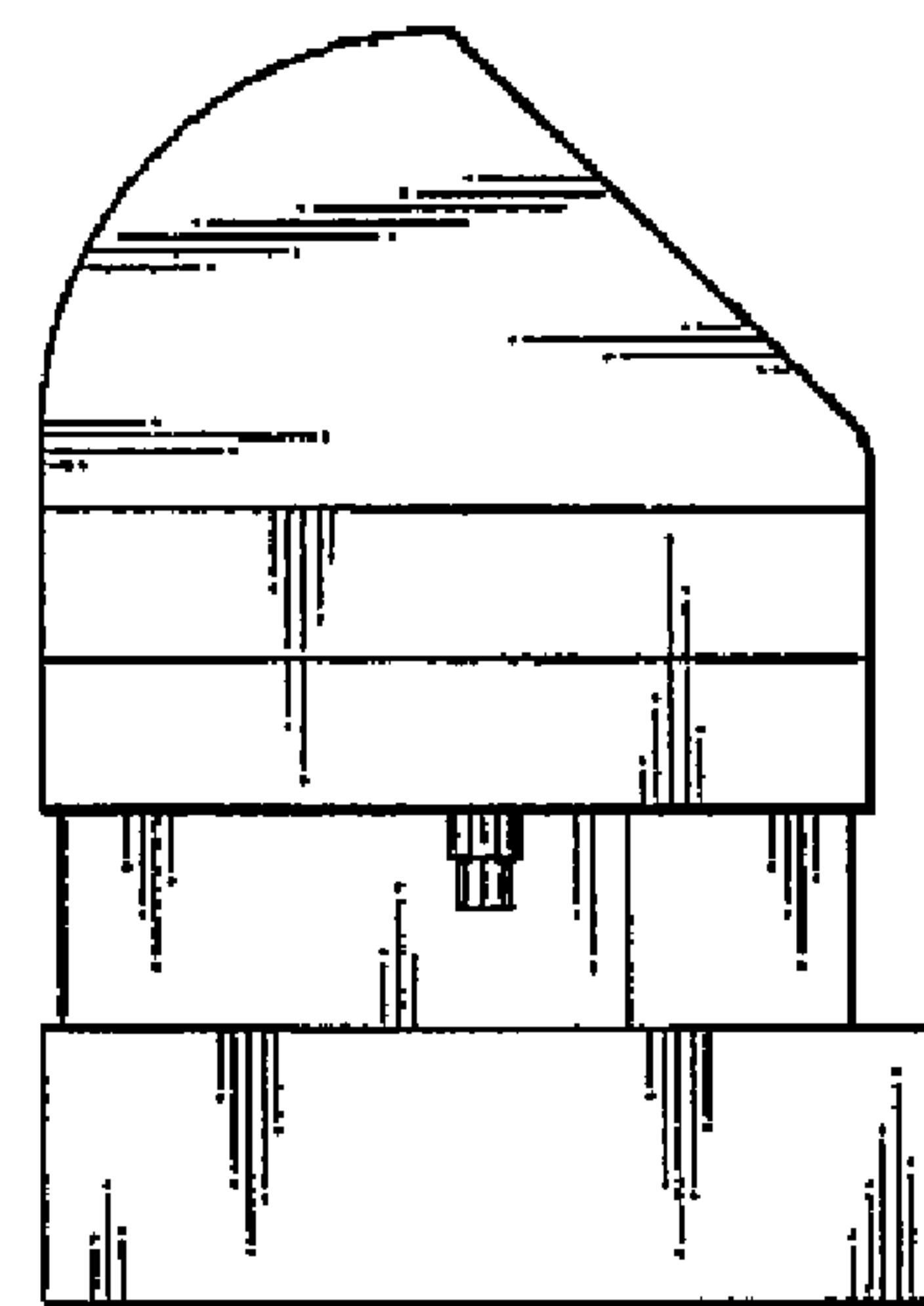


FIG. 13

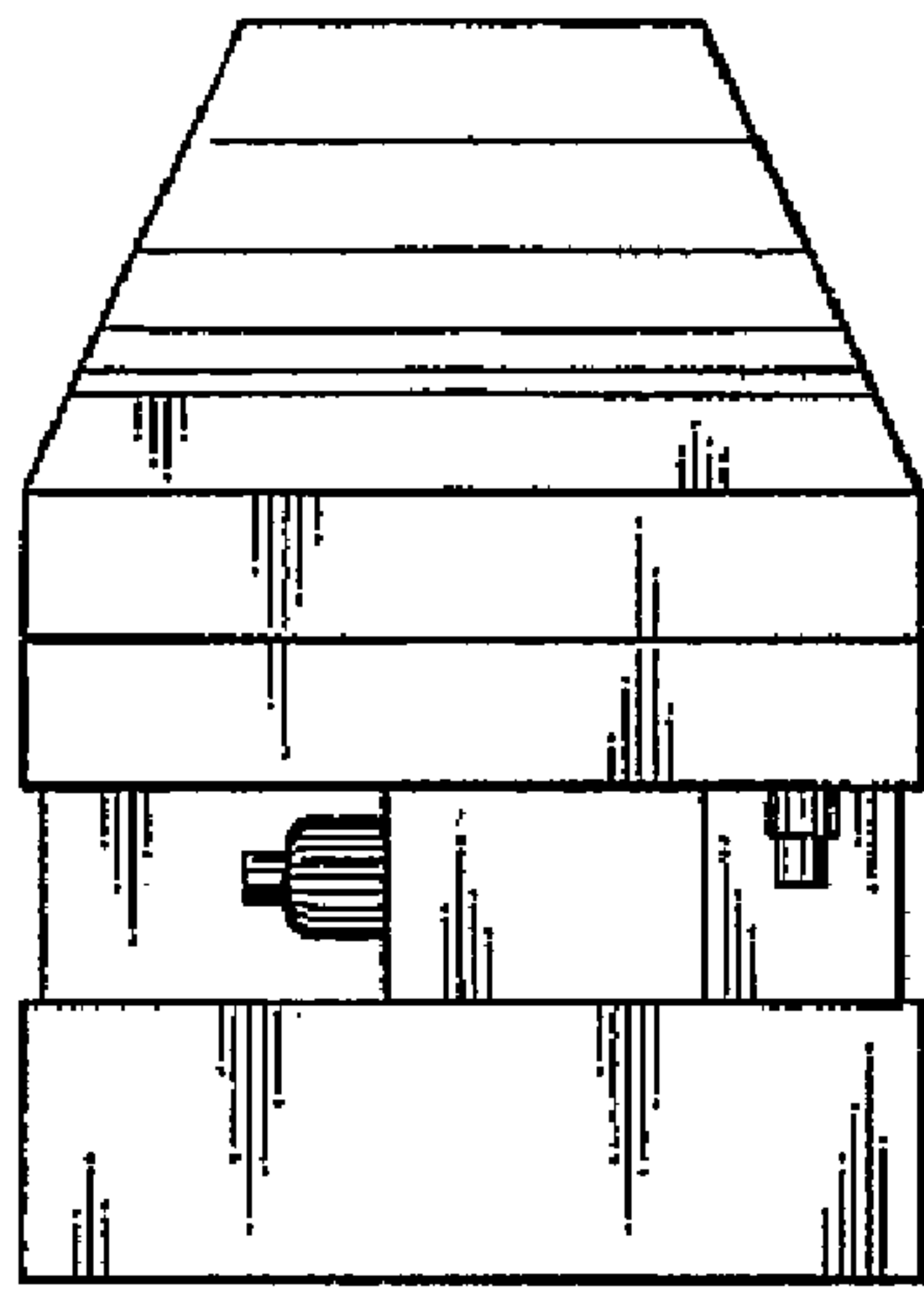


FIG. 14

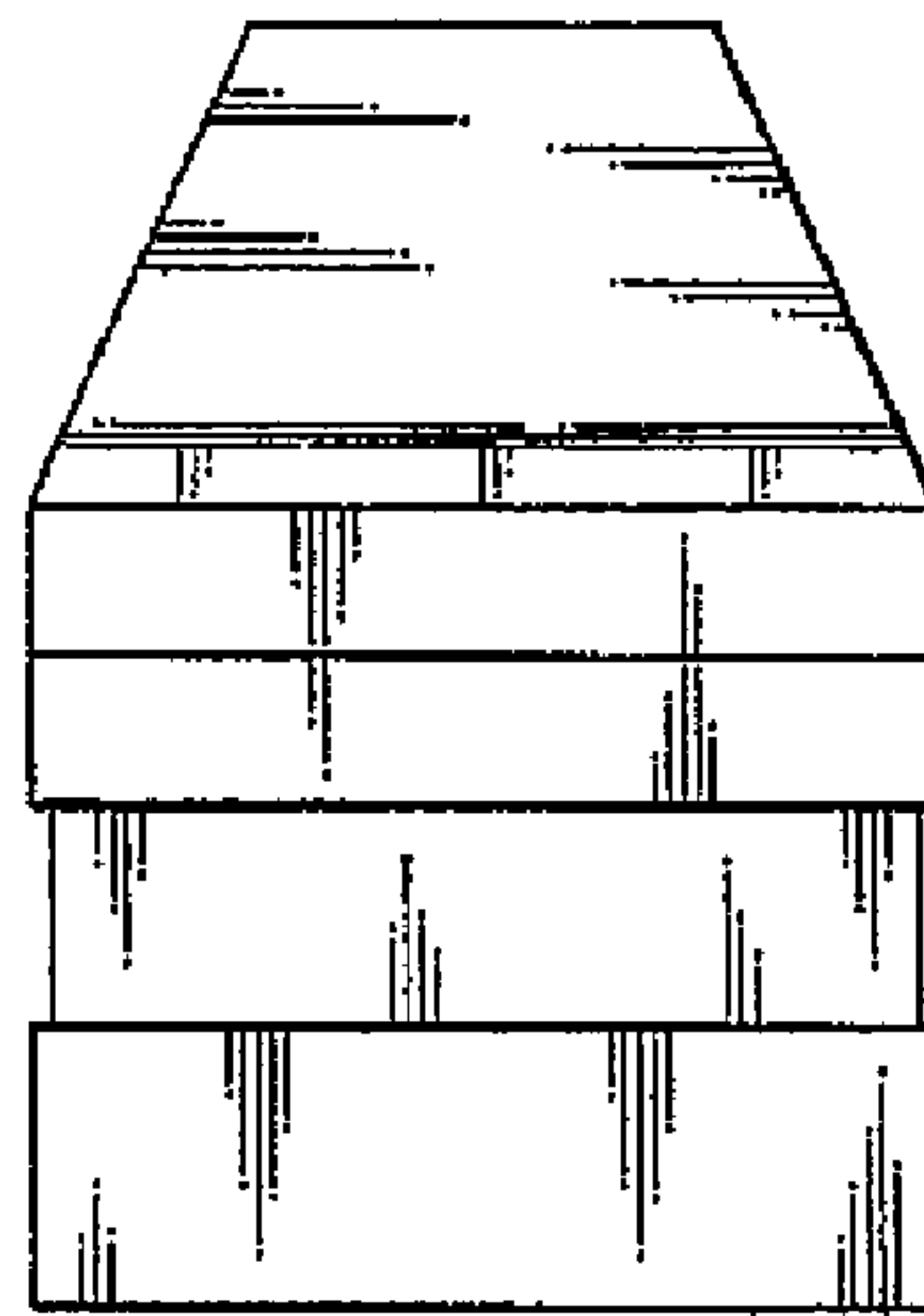


FIG. 15

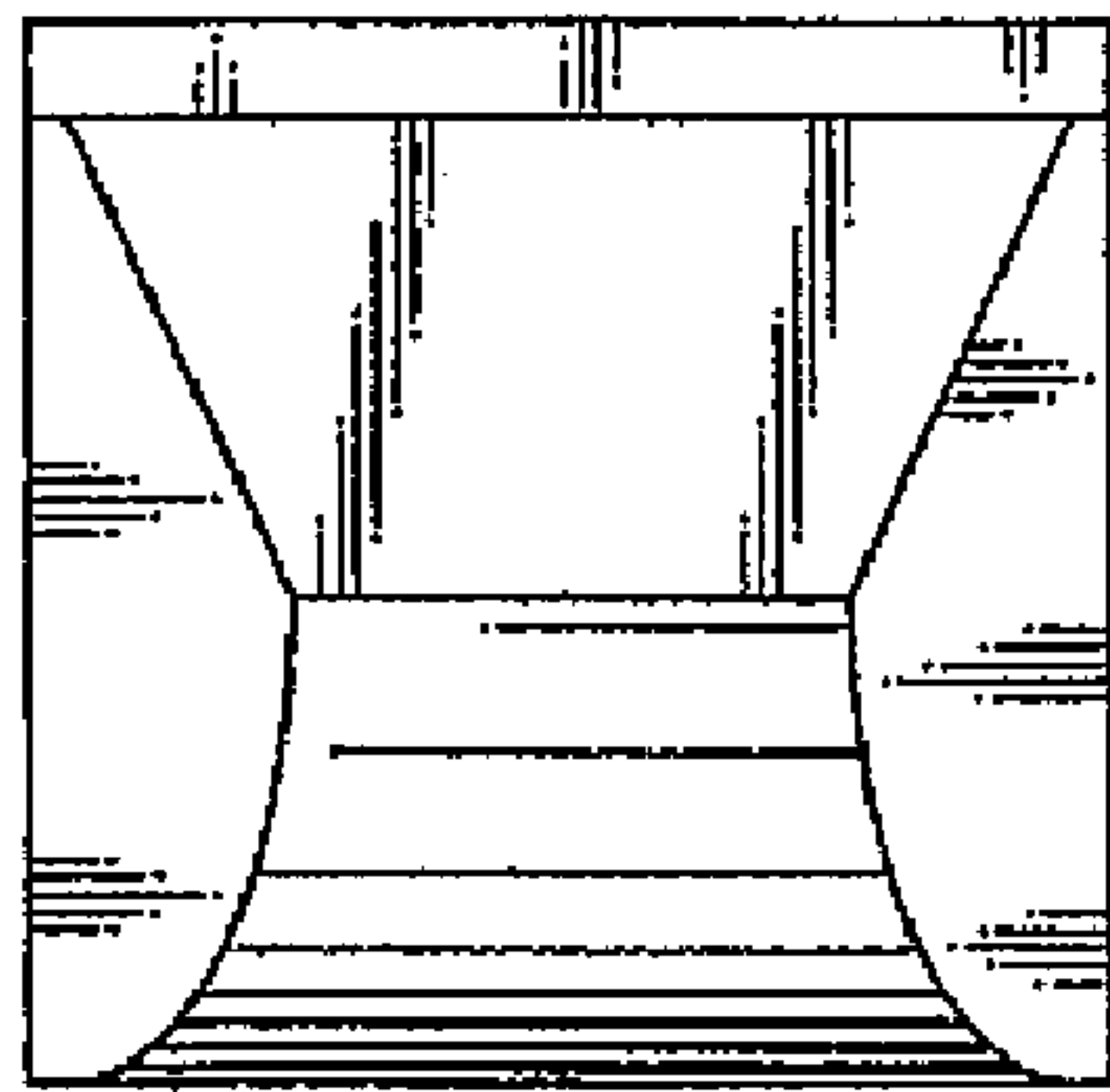


FIG. 16

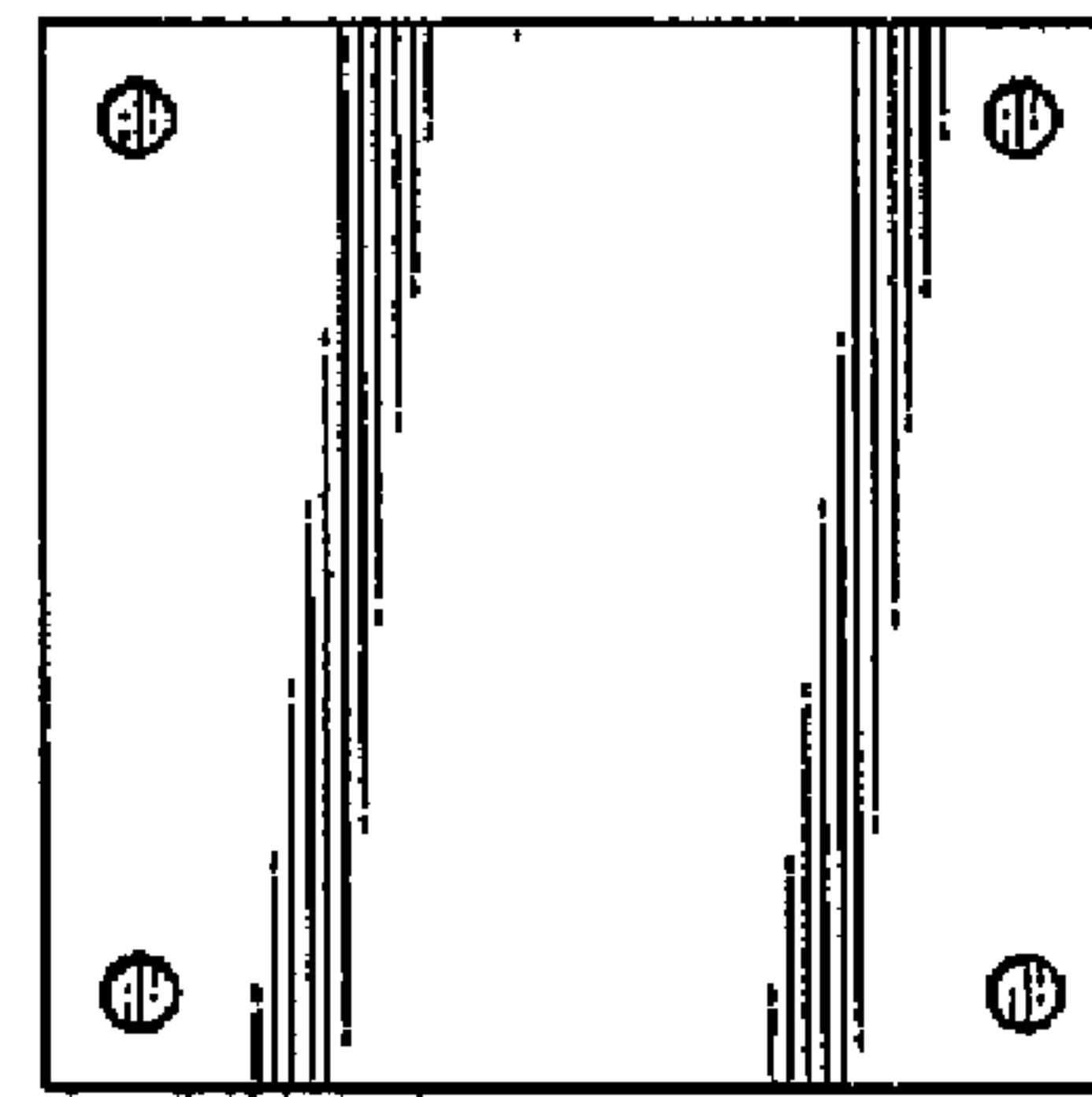


FIG. 17

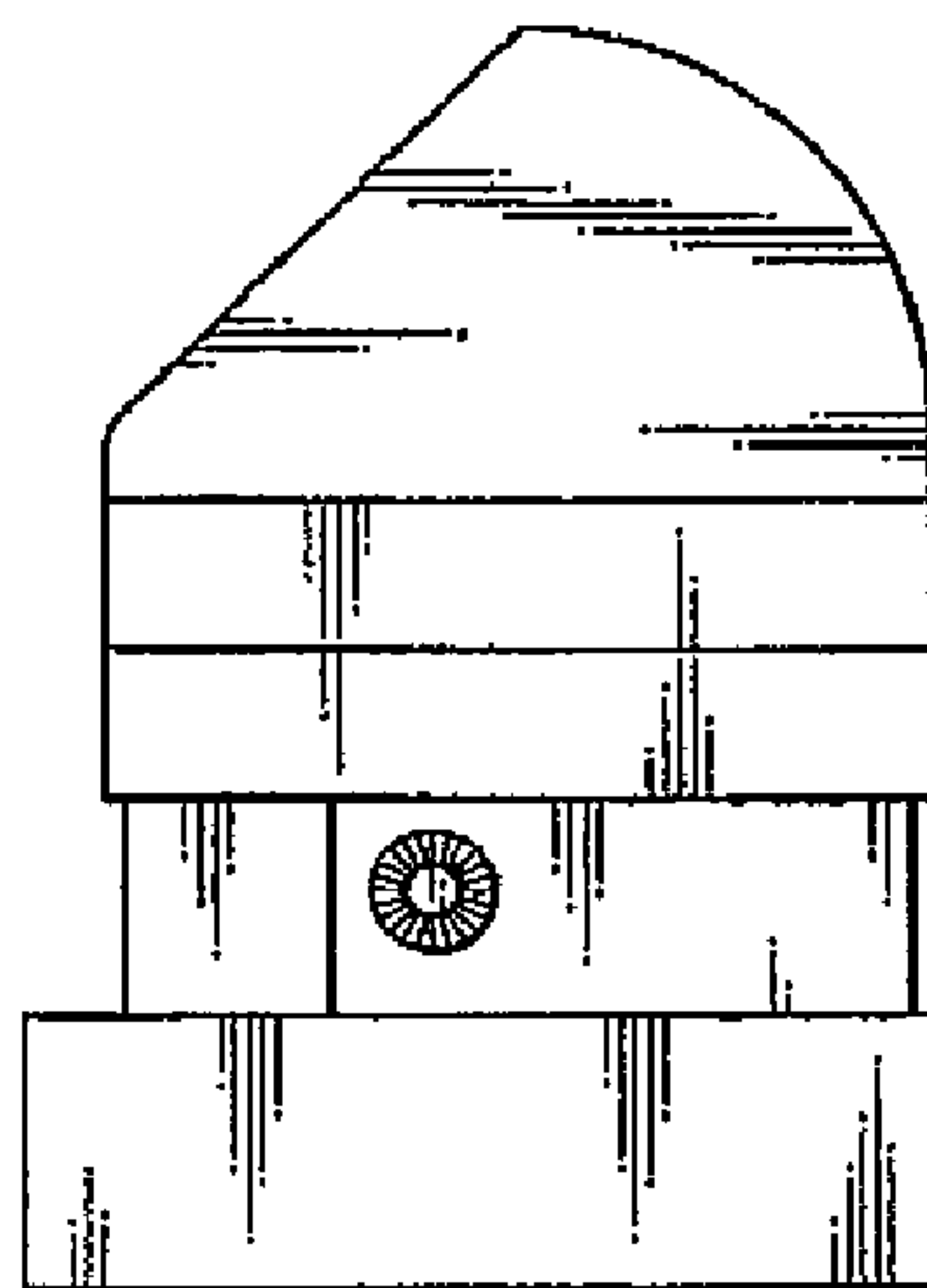


FIG. 18

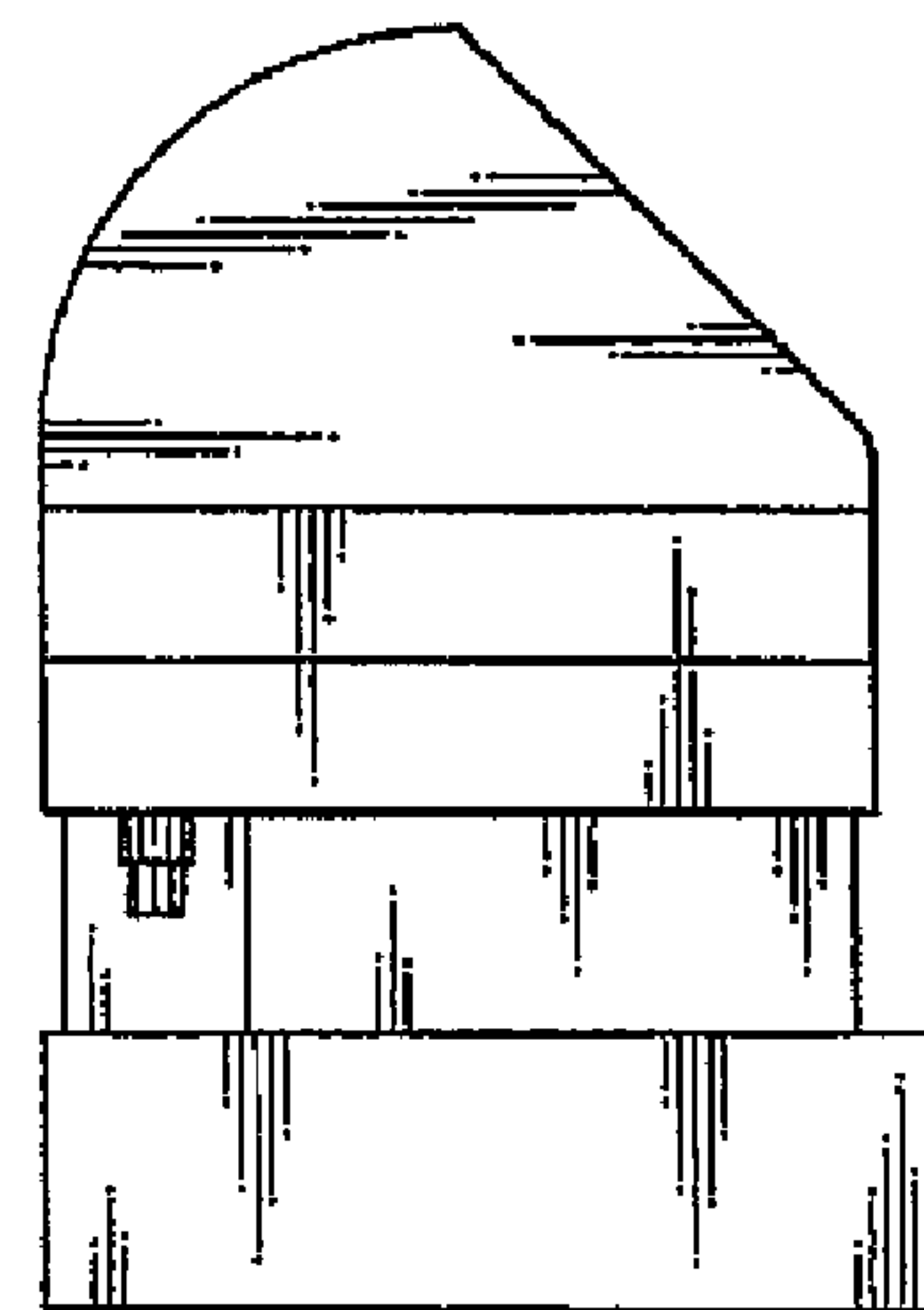


FIG. 19

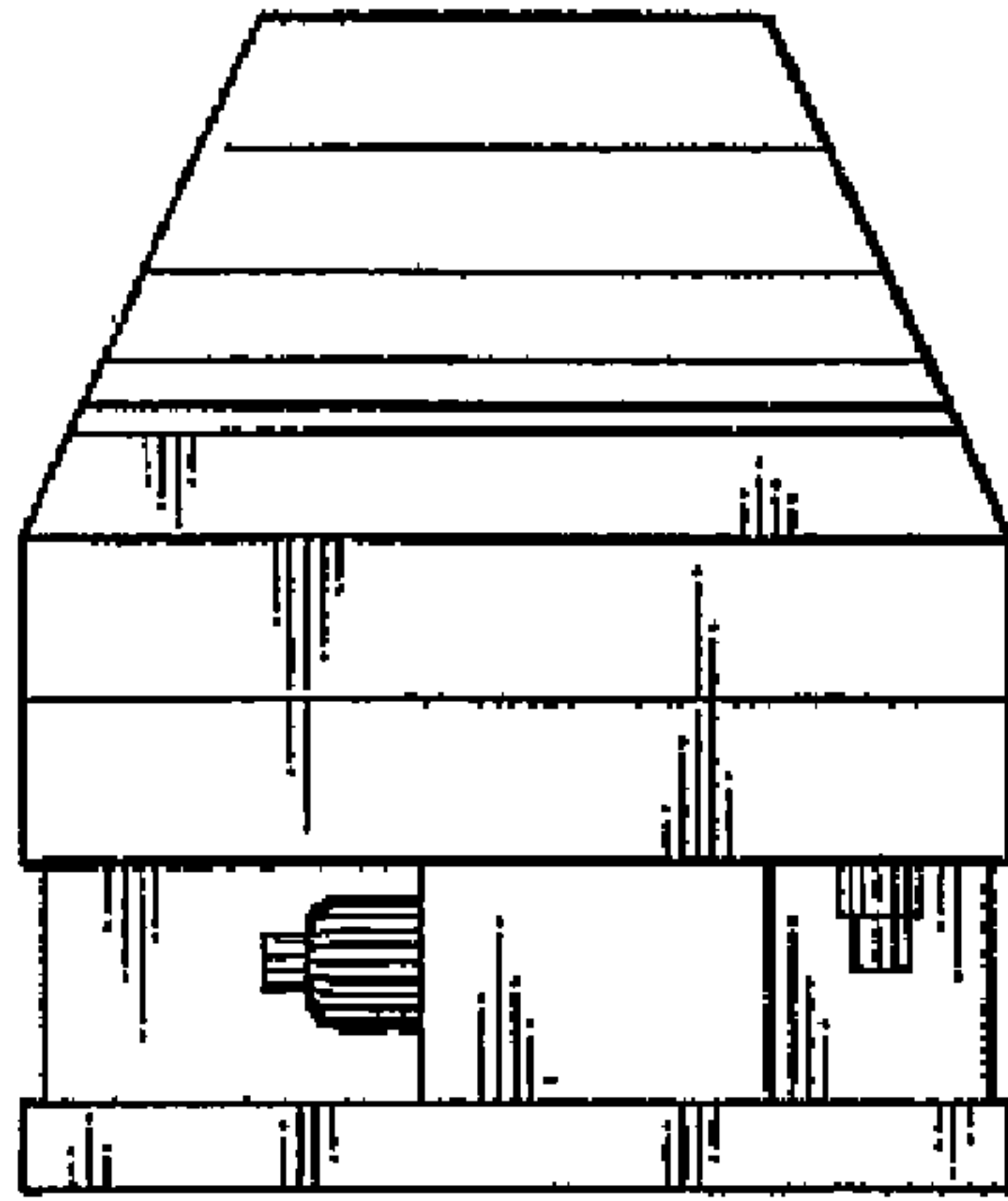


FIG. 20

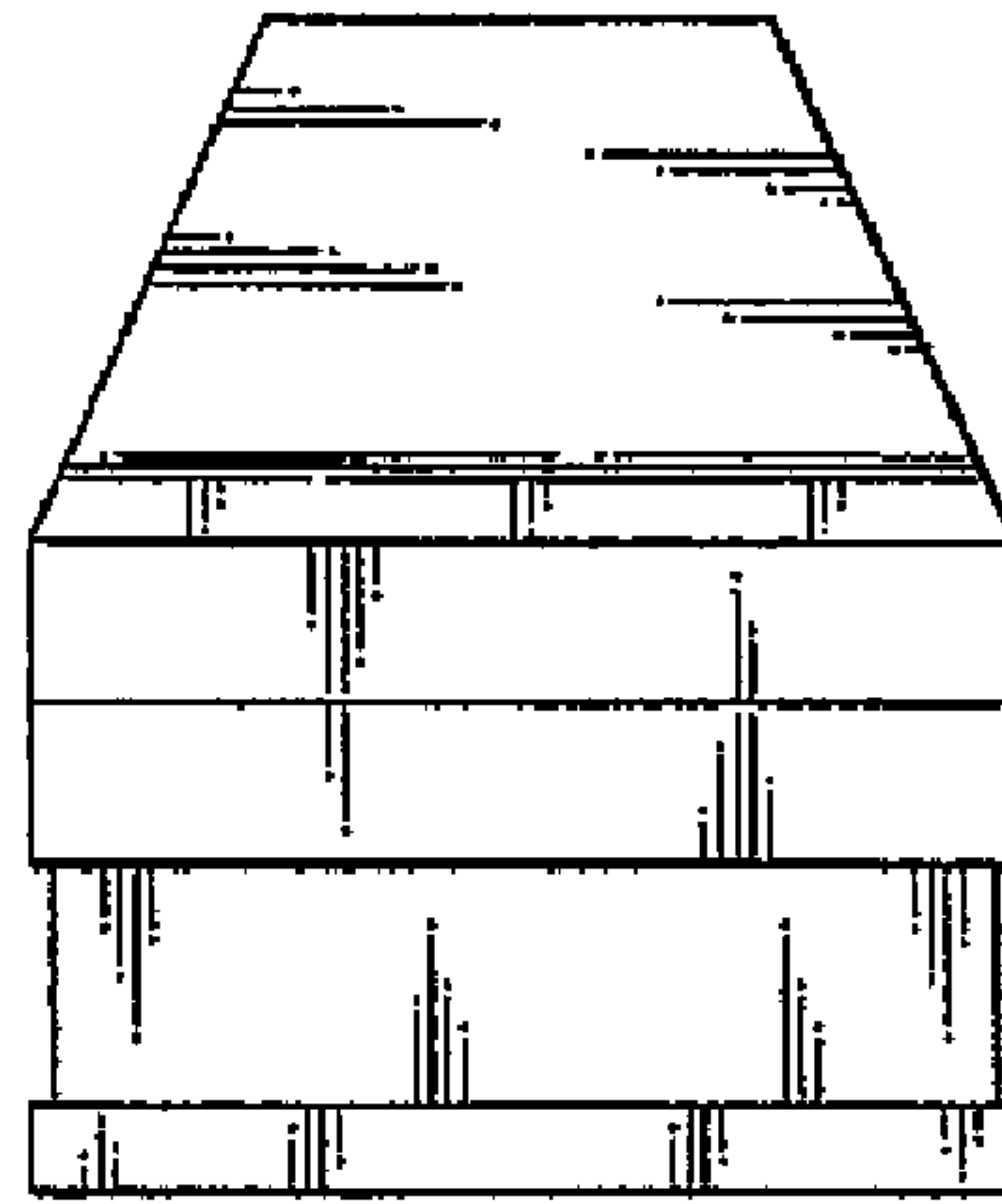


FIG. 21

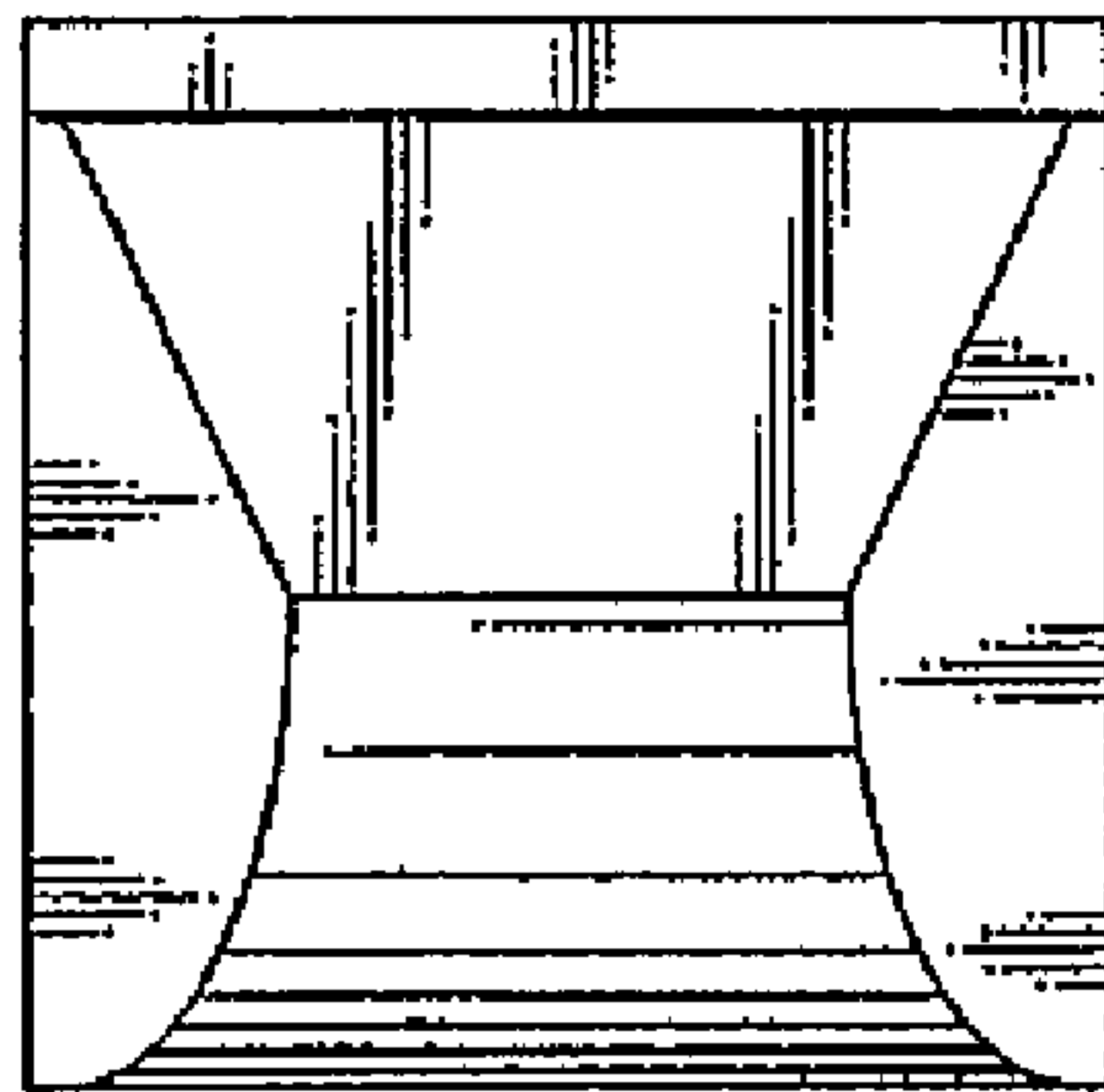


FIG. 22

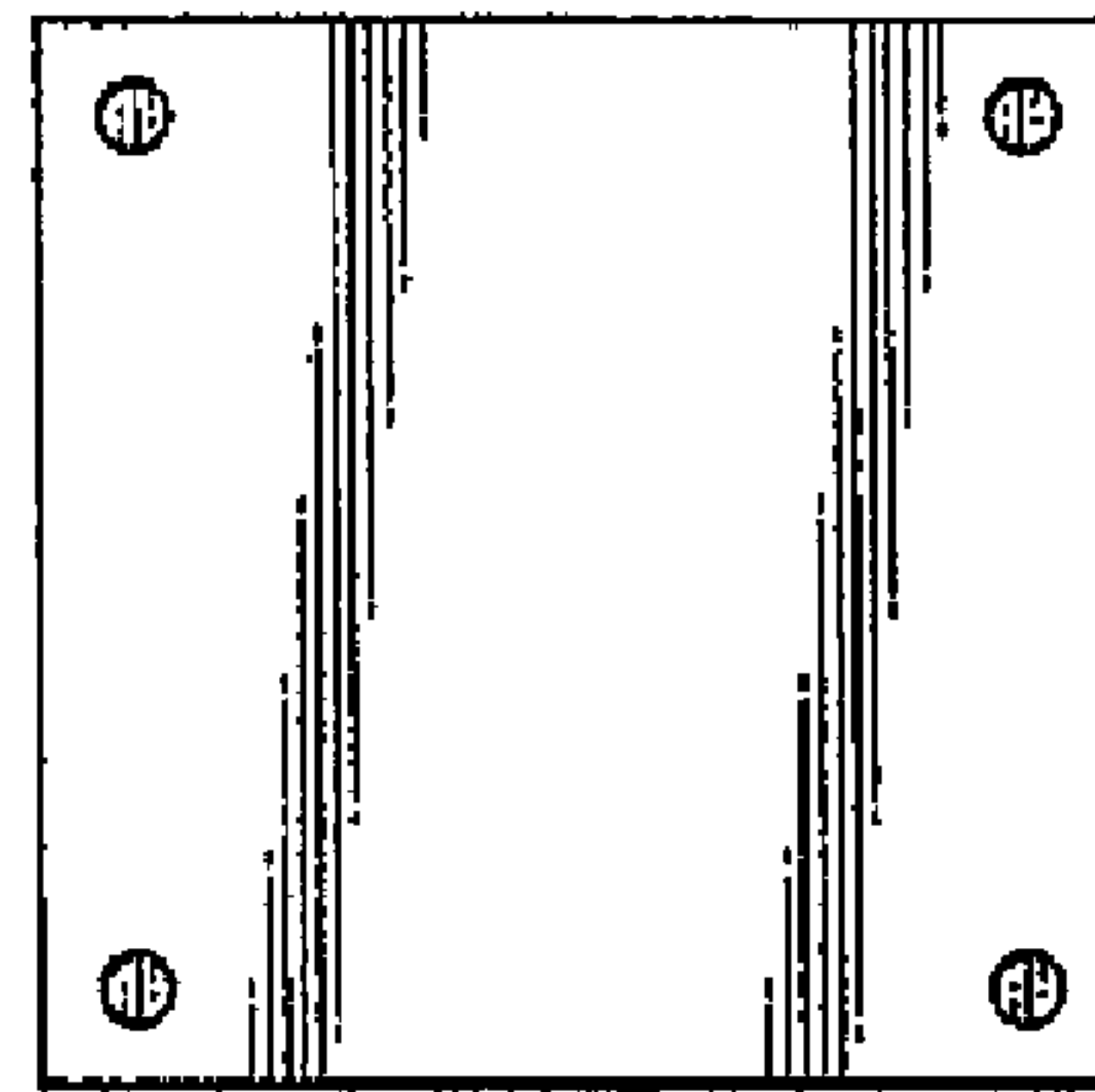


FIG. 23

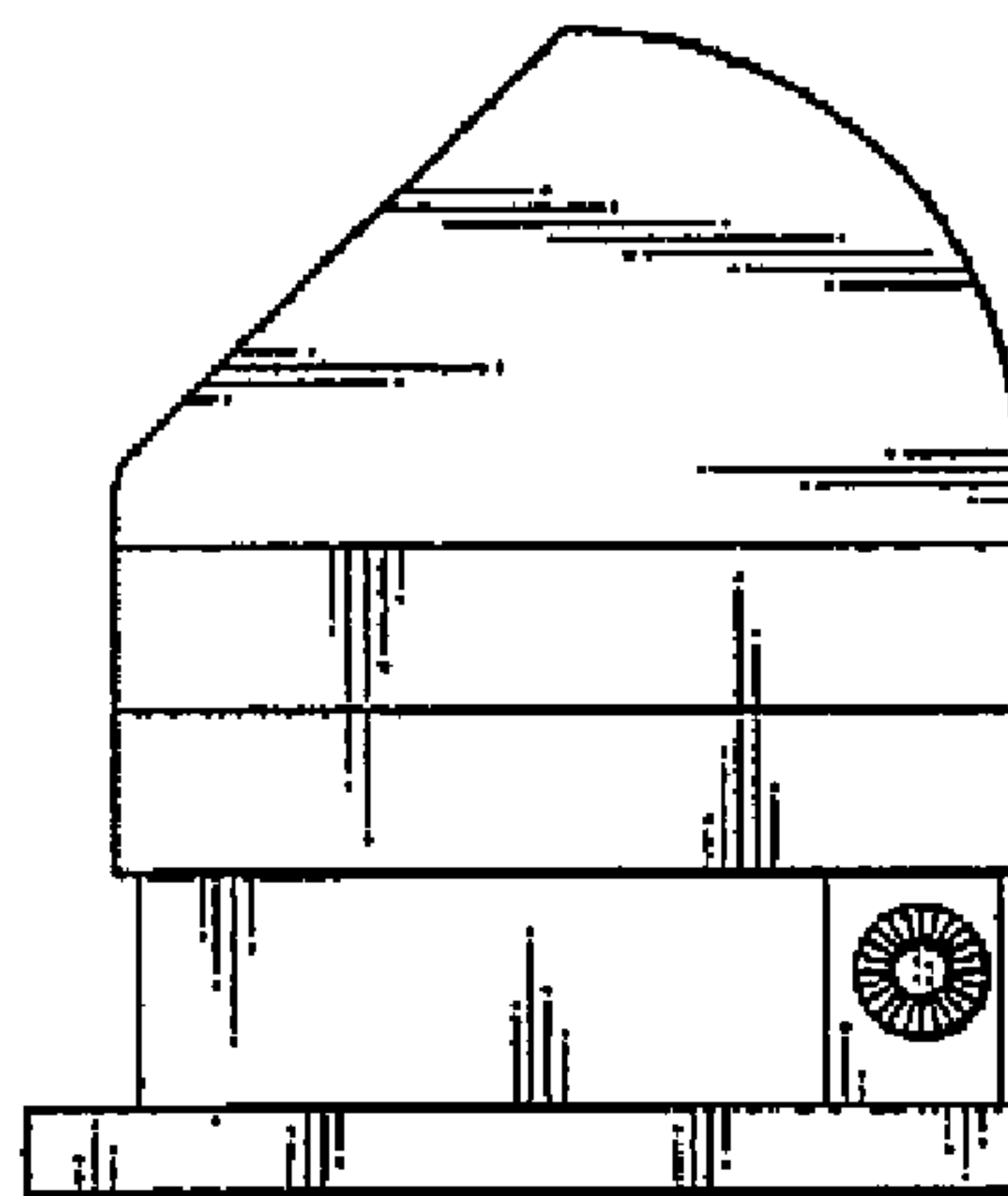


FIG. 24

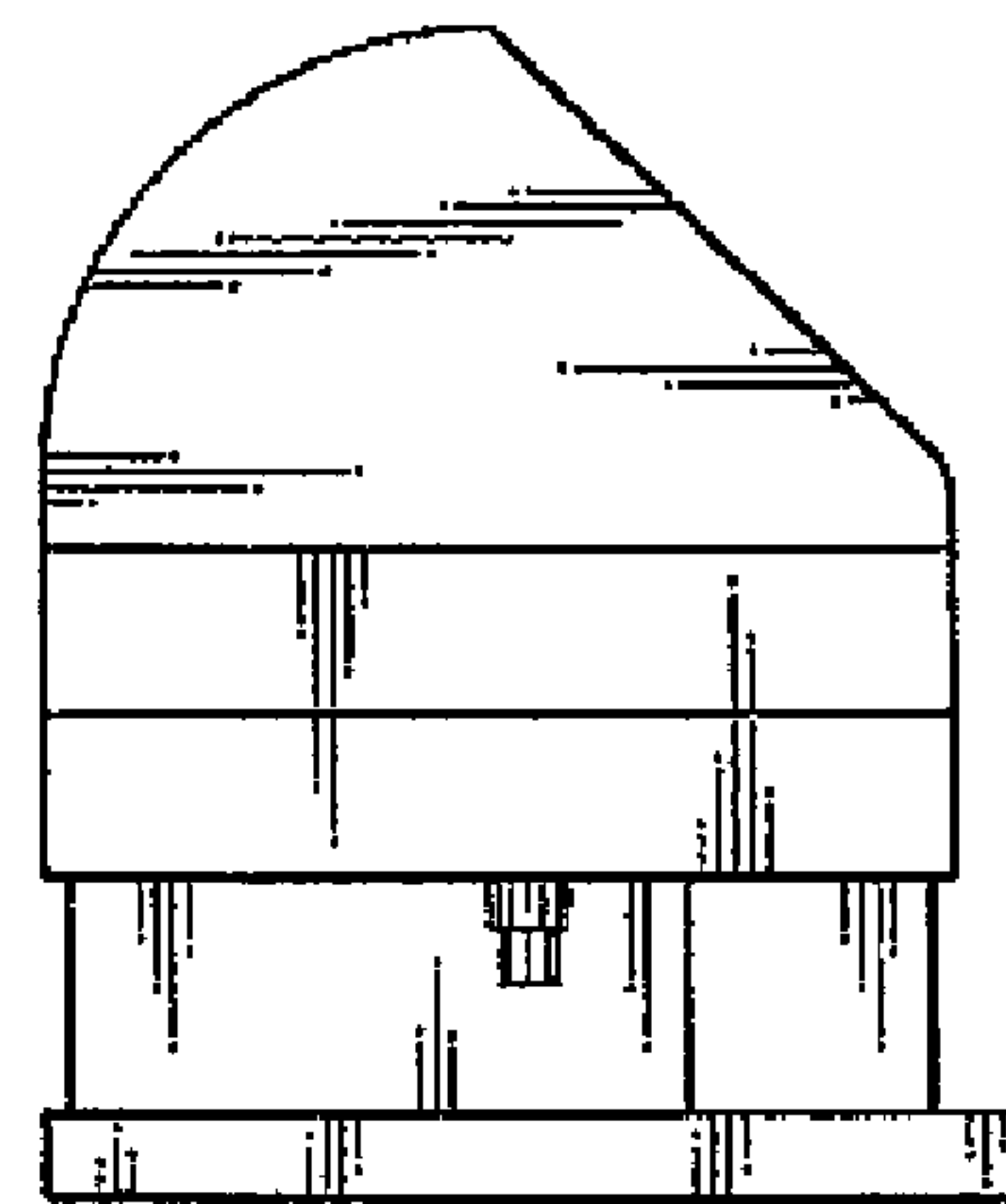


FIG. 25